Search Notes

Application/Control No.	Applicant(s)/Pat nt und r Re xamination	
09/664,565	NAIK, TEJAS	
Examiner	Art Unit	
Hanh Nguyen	2662	

SEARCHED					
Class	Subclass	Date	Examiner		
370	238	6/10/2005	HN		
	395.1				
	392				
	400				
	396	-			
	397				
	216				
	218				
	399	9/11/2005	HN		
	338				
	404				
	401				
	409				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SE/ (INCLUDING	ARCH NOTES SEARCH ST	; RATEGY	)
		DATE	EXMR
east	ε	5/10/2005	ни
East	S	9/11/2005	HN